

High Input Voltage 10A PWM Converter With Low Iq

### Features

- Adjustable Output Voltage from +0.8V to +12V
   0.8V Reference Voltage
  - +1%Accuracy over Temperature
- Operates from An Input Battery Voltage Range of +2.7V to +28V
- 10A Continous Output Current
- 12A Peak Output Current
- Power-On-Reset Monitoring on VCC pin
- Excellent line and load transient responses
- PFM mode for increased light load efficiency
- Programmable PWM Frequency from 100kHz to 1000kHz
- Integrated 22mΩ at VCC=5V N-Channel MOSFET For High Side
- Integrated 7mΩ at VCC=5V N-Channel MOSFET For Low Side
- Integrated Bootstrap Forward P-CH MOSFET
- External Adjustable Soft-Start and Soft-Stop
- Selectable Forced PWM or automatic PFM/PWM mode
- Power Good Monitoring
- 70% Under-Voltage Protection
- 125% Over-Voltage Protection
- Current-Limit Protection
  - Using Sense Low-Side MOSFET's  $R_{\scriptscriptstyle DS(ON)}$
- Over-Temperature Protection
- TQFN-22A 4mmx4mm package
- Lead Free and Green Device Available (RoHS Compliant)

### **General Description**

The APW8742 is a 10A, synchronous, step-down converter with integrated 22m $\Omega$  N-channel High-Side MOSFET and 7m $\Omega$  Low-Side MOSFET. The APW8742 steps down high voltage to generate low-voltage chipset or RAM supplies in notebook computers.

The APW8742 provides excellent transient response and accurate DC voltage output in either PFM or PWM Mode. In Pulse Frequency Mode (PFM), the APW8742 provides very high efficiency over light to heavy loads with load-ingmodulated switching frequencies. In PWM Mode, the converter works nearly at constant frequency for low-noise requirements.

The APW8742 is equipped with accurate current-limit, output under-voltage, and output over-voltage protections, perfect for various applications. A Power-On-Reset function monitors the voltage on VCC to prevent wrong operation during power-on. The APW8742 has external adjustable soft-start and built-in an integrated output discharge method for soft stop. A soft-start ramps up the output voltage with programmable timing to reduce the start-up current. A soft-stop function actively discharges the output capacitors.

The APW8742 is available in TQFN4x4-22A (Power PAK).

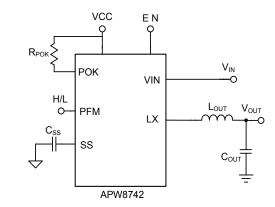
### **Applications**

- Notebook
- Mother Board
- Table PC
- Hand-Held Portable
- AIO PC
- Set-top boxes
- LCD TV

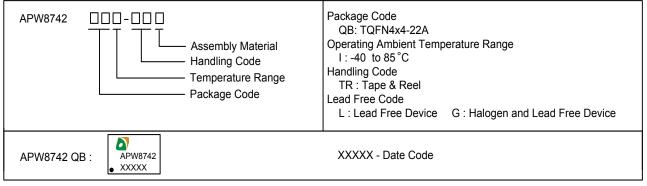
ANPEC reserves the right to make changes to improve reliability or manufacturability without notice, and advise customers to obtain the latest version of relevant information to verify before placing orders.



# **Simplified Application Circuit**

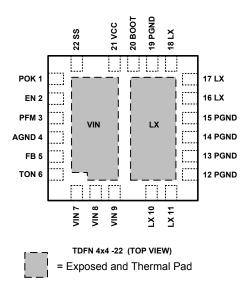


## **Ordering and Marking Information**



Note: ANPEC lead-free products contain molding compounds/die attach materials and 100% matte tin plate termination finish; which are fully compliant with RoHS. ANPEC lead-free products meet or exceed the lead-free requirements of IPC/JEDEC J-STD-020D for MSL classification at lead-free peak reflow temperature. ANPEC defines "Green" to mean lead-free (RoHS compliant) and halogen free (Br or Cl does not exceed 900ppm by weight in homogeneous material and total of Br and Cl does not exceed 1500ppm by weight).

# Pin Configuration





### Absolute Maximum Ratings (Note 1)

Symbol	Parameter	Rating	Unit
V <sub>VCC</sub>	VCC Supply Voltage (VCC to AGND)	-0.3 ~ 7	V
V <sub>IN</sub>	VIN Supply Voltage (VIN to AGND)	-0.3 ~ 30	V
V <sub>TON</sub>	TON Supply Voltage (TON to AGND)	-0.3 ~ 30	V
$V_{\text{BOOT-GND}}$	BOOT Supply Voltage (BOOT to AGND)	-0.3 ~ 37	V
V <sub>BOOT</sub>	BOOT Supply Voltage (BOOT to LX)	-0.3 ~ 7	V
$V_{\text{GND}}$	AGND to PGND	-0.3 ~ +0.3	V
	All Other Pins (POK, EN, FB, SS and PFM to AGND)	-0.3 ~ 7	V
V <sub>LX</sub>	LX Voltage (LX to GND) <20ns pulse width >20ns pulse width	-5 ~ 32 -0.3 ~ 30	V
TJ	Junction Temperature	150	°C
T <sub>STG</sub>	Storage Temperature	-65 ~ 150	°C
	Maximum Lead Soldering Temperature(10 Seconds)	260	°C

Note1: Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

## **Thermal Characteristics**

Symbol	Parameter	Typical Value	Unit
$\theta_{JA}$	Junction-to-Ambient Resistance in free air (Note 2)	50	°C/W

Note 2:  $\theta_{JA}$  is measured with the component mounted on a high effective thermal conductivity test board in free air.

### **Recommended Operating Conditions** (Note 3)

Symbol	Parameter	Range	Unit
V <sub>VCC</sub>	VCC Supply Voltage	4.5 ~ 5.5	V
V <sub>IN</sub>	Converter Input Voltage	2.7 ~ 28	V
V <sub>OUT</sub>	Converter Output Voltage	0.8 ~ 13.2	V
I <sub>OUT</sub>	Converter Output Current	0 ~ 10	А
CIN	PWM1/2 Converter Input Capacitor (MLCC)	10 ~	μF
C <sub>VCC</sub>	VCC Output Capacitor (MLCC)	1.0 ~	μF
T <sub>A</sub>	Ambient Temperature	-40 ~ 85	°C
TJ	Junction Temperature	-40 ~ 125	°C

Note 3: Refer to the application circuit for further information.



### **Electrical Characteristics**

Unless otherwise specified, these specifications apply over  $V_{IN}$ =12V,  $V_{EN}$ =5V and  $T_A$ = -40 to 85 °C. Typical values are at  $T_A$ =25°C.

Symphol	Baramatar	Tast sandition		APW8742		11
Symbol	Parameter	Test condition	Min.	Тур.	Max.	Uni
VOUT AND	VFB VOLTAGE					
$V_{\text{REF}}$	Reference Voltage		-	0.8	-	v
	Regulation Accuracy	$T_{A} = -40 ^{\circ}\text{C} \sim 85 ^{\circ}\text{C}$	-1.0	-	+1.0	%
I <sub>FB</sub>	FB Input Bias Current	FB=0.75V	-	0.02	-	μA
TSTOP	TSTOP Output Discharge Time $EN=GND, V_{IN}=12V, VCC=5V, V_{OUT}=1V \text{ to } 0V, C_{OUT}=88uF, T_A=25 \text{ °C}$		-	660	-	μS
SUPPLY C	URRENT		•			
$I_{VCC\_NORMAL}$	VCC Quiescent Supply Current	EN=5V,FB=0.835V,VCC=5V	-	17	25	μA
$I_{VCC\_SHDN}$	VCC Shutdown Current	EN=GND, VCC=5V	-	1.5	4	μA
ON-TIME T	IMER AND INTERNAL SOFT START					
$T_{ON}$	Nominal on time	$V_{IN}$ =12V, $V_{OUT}$ =1V, $R_{TON}$ =100k $\Omega$	200	250	300	ns
$F_{sw}$	Frequency adjustable range		100	-	1000	kHz
T <sub>OFF(MIN)</sub>	Minimum off time	V <sub>FB</sub> =0.75V, V <sub>LX</sub> =-0.1V	-	250	-	ns
I <sub>ss</sub>	Internal Soft Start Current	V <sub>ss</sub> =0V, Css=0.001µF to 0.1µF	8	10	12	μA
T <sub>ss</sub>	Internal Soft Start Time	EN High to POK High	-	330*Css	-	ms
GATE DRIV	/ER					
	High Side MOSFET On Resistance	V <sub>IN</sub> =12V , VCC=5V	-	22	30	mΩ
	Low Side MOSFET On Resistance	V <sub>IN</sub> =12V , VCC=5V	-	7	10	mΩ
BOOTSTR	AP SWITCH			1		
$R_{\scriptscriptstyle B}$	Bootstrap Switch On Resistance	$V_{PVCC} - V_{BOOT-GND}$ , $I_B = 10mA$	-	50	70	Ω
I <sub>R</sub>	Reverse Leakage	$V_{\text{BOOT-GND}}$ = 30V, $V_{\text{LX}}$ = 25V, $V_{\text{PVCC}}$ = 5V	-	-	0.5	μA
VCC POR	THRESHOLD			L		
$V_{\text{VCC_THF}}$	Rising VCC POR Threshold Voltage		4.25	4.35	4.45	V
	VCC POR Hysteresis		-	100	-	mV
CONTROL	INPUTS		1	<u> </u>	1	L
	EN High-Level Input Voltage		2.5	-	vcc	V
	EN Low-Level Input Voltage		0	-	0.5	v
	EN Leakage	EN=0V	-	0.1	-	μA
	PFM High-Level Input Voltage		2.5	-	vcc	v
	PFM Low-Level Input Voltage		0	-	0.5	v
			1			1



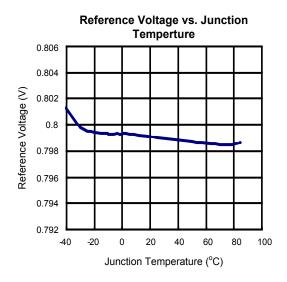
### **Electrical Characteristics**

Unless otherwise specified, these specifications apply over  $V_{IN}$ =12V,  $V_{EN}$ =5V and  $T_A$ = -40 to 85 °C. Typical values are at  $T_A$ =25°C.

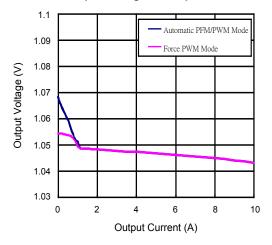
0h.al	Demension	Took a sur diktory		APW8742		
Symbol	Parameter	Test condition	Min.	Тур.	Max.	Unit
POWER-O	K INDICATOR					<u>.</u>
V	POK Threshold	POK in from Lower (POK Goes High)	87	90	93	%
V <sub>POK</sub> PO	FOR Theshold	POK out from Normal (POK Goes Low)	120	125	130	%
I <sub>POK</sub>	POK Leakage Current	V <sub>POK</sub> =5V	-	0.1	-	μA
	POK Sink Current	V <sub>POK</sub> =0.5V	1.25	7.5	-	mA
	POK Out Debounce Time	When run away 90%	-	20	-	μs
	POK Enable Delay Time	From EN High to POK High	-	Tss	-	ms
CURRENT	SENSE	·				
I <sub>OCP</sub>	OCP Threshold	Valley Current of IL	15	-	-	A
	Zero Crossing Comparator Offset	V <sub>GND-LX</sub> Voltage, PFM=0V	-5	0	5	mV
PROTECTI	ON	,				
V <sub>UV</sub>	UVP Threshold		65	70	75	%
	UVP Debounce Interval		-	16	-	μs
	UVP Enable Delay	EN high to UVP workable	-	Tss	-	ms
V <sub>OVR</sub>	OVP Rising Threshold	OVP Occur	120	125	130	%
	OVP Propagation Delay	V <sub>FB</sub> Rising, Over voltage=10mV	-	3	-	μs
T <sub>OTR</sub>	OTP Rising Threshold		-	145	-	°C
	OTP Hysteresis		-	45	-	°C

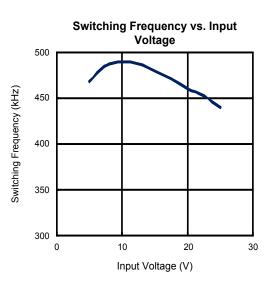


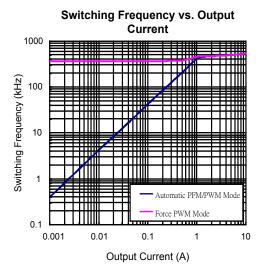
# **Typical Operating Characteristics** Refer to the typical application circuit. The test condition is $V_{IN}$ =19V, $T_A$ = 25°C unless otherwise specified.



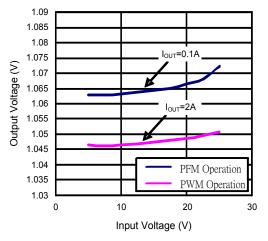
**Output Voltage vs Output Current** 







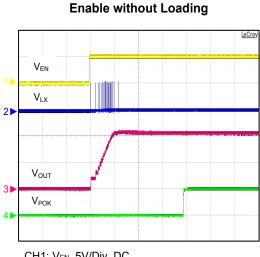
**Output Voltage vs Input Voltage** 



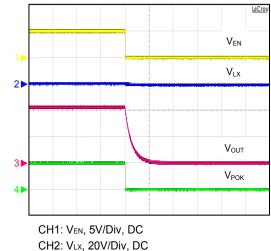


# **Operating Waveforms**

Refer to the typical application circuit. The test condition is V<sub>IN</sub>=19V, T<sub>A</sub>= 25°C unless otherwise specified.

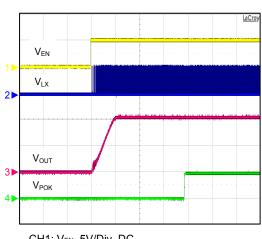


CH1: VEN, 5V/Div, DC CH3: Vout, 500mV/Div, DC CH4: VPOK, 5V/Div, DC TIME: 1ms/Div



Shutdown without Loading

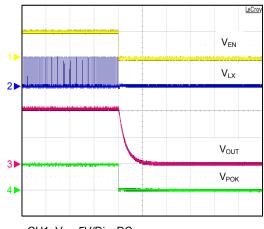
CH3: VOUT, 500mV/Div, DC CH4: VPOK, 5V/Div, DC TIME: 2ms/Div



**Enable with Loading** 

CH1: VEN, 5V/Div, DC CH2: VLX, 20V/Div, DC CH3: Vout, 500mV/Div, DC CH4: VPOK, 5V/Div, DC TIME: 1ms/Div

Shutdown with Loading



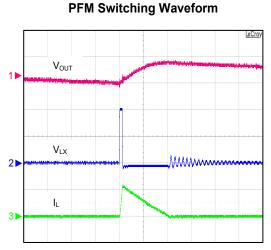
CH1: VEN, 5V/Div, DC CH2: VLX, 20V/Div, DC CH3: VOUT, 500mV/Div, DC CH4: VPOK, 5V/Div, DC TIME: 50µs/Div

CH2: VLX, 20V/Div, DC

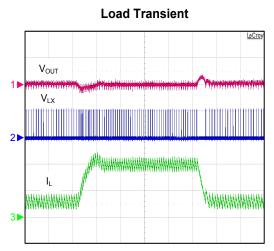


# **Operating Waveforms**

Refer to the typical application circuit. The test condition is  $V_{IN}$ =19V,  $T_A$ = 25°C unless otherwise specified.

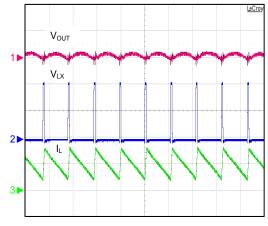


 $\begin{array}{l} CH1: V_{\text{OUT}}, 50mV/Div, AC\\ CH2: V_{\text{LX}}, 10V/Div, DC\\ CH3: I_{\text{L}}, 2A/Div, DC\\ TIME: 1\mu s/Div \end{array}$ 



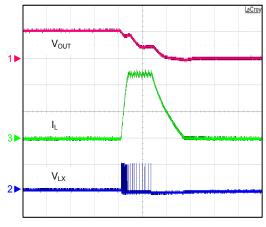
CH1: Vout, 100mV/Div, AC CH2: VLx, 20V/Div, DC CH3: IL, 5A/Div, DC TIME:  $20\mu$ s/Div

**PWM Switching Waveform** 



CH1: Vout, 50mV/Div, AC CH2: V<sub>LX2</sub>, 10V/Div, DC CH3: I<sub>L</sub>, 2A/Div, DC TIME: 2µs/Div

**Short Circuit Protection** 



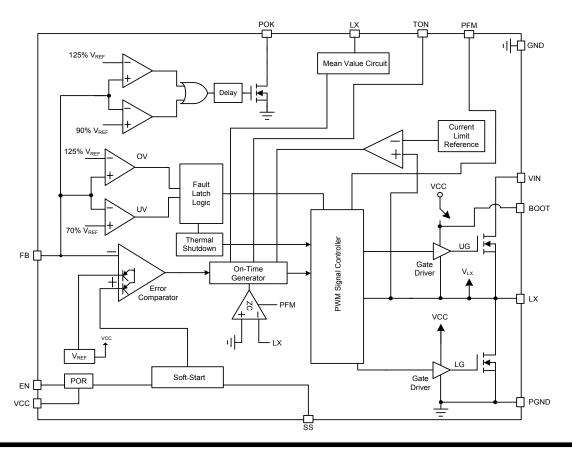
CH1: Vout, 1V/Div, DC CH2: VLx, 20V/Div, DC CH3: IL, 10A/Div, DC TIME: 20µs/Div



### **Pin Description**

PIN NO. NAME		FUNCTION
		FUNCTION
1	РОК	Power-Good Output Pin of PWM. POK is an open-drain output used to indicate the status of the PWM output voltage. Connect the POK in to +5V through a pull-high resistor.
2 EN PWM Enable. PWM is enabled when EN=1. When EN=0, PWM is in shutdown.		
3 PFM PFM Selection Input. When the PFM is above high logic level, the Device is in force PWM mode. When PFM is below low logic level, the device is in automatic PFM/PWM Mode.		PFM Selection Input. When the PFM is above high logic level, the Device is in force PWM mode. When the PFM is below low logic level, the device is in automatic PFM/PWM Mode.
4	AGND	Signal Ground for The IC.
5	FB	Output Voltage Feedback Pin. This pin is connected to the resistive divider that set the desired output voltage. The POK, UVP, and OVP circuits detect this signal to report output voltage status.
6	TON	This Pin is Allowed to Adjust The Switching Frequency. Connect a resistor $R_{TON}$ from TON pin to VIN pin.
7, 8, 9	7, 8, 9 VIN Battery Voltage Input Pin. VIN powers linear regulators and is also used for the constant or time one-shot circuits.	
10, 11, 16~18 LX for PWM. Connect this pin to the Source of t		Junction Point of The High-Side MOSFET Source, Output Filter Inductor and The Low-Side MOSFET Drain for PWM. Connect this pin to the Source of the high-side MOSFET. LX serves as the lower supply rail for the UGATE high-side gate driver. LX is the current-sense input for the PWM.
12~15,	DOND	
19	PGND	Power Ground of The LGATE Low-Side MOSFET Drivers.
20	воот	Supply Input for The UGATE Gate Driver and an internal level-shift circuit. Connect to an external capacitor to create a boosted voltage suitable to drive a logic-level N-channel MOSFET.
21	VCC	Supply Voltage Input Pin for Control Circuitry, Connect +5V from the VCC pin to the GND pin. Decoupling at
1		least 1µF of a MLCC capacitor from the VCC pin to the AGND pin.
22	SS	Soft Start Output. Connect a capacitor to GND to set the soft start interval.

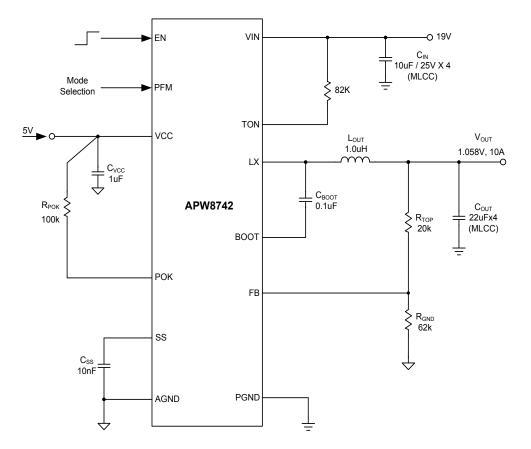
# **Block Diagram**





# **Typical Application Circuit**

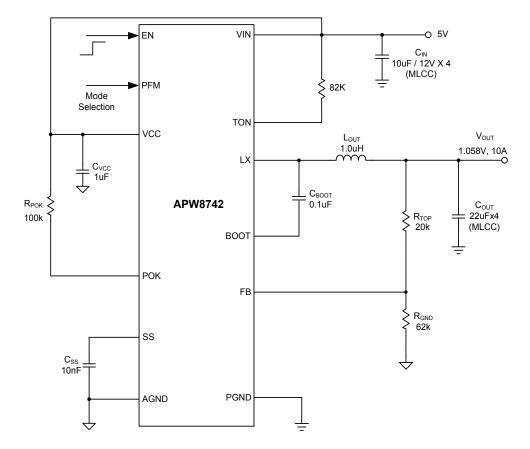
When  $V_{IN}$ =19V, Dual Power Input:





# **Typical Application Circuit**

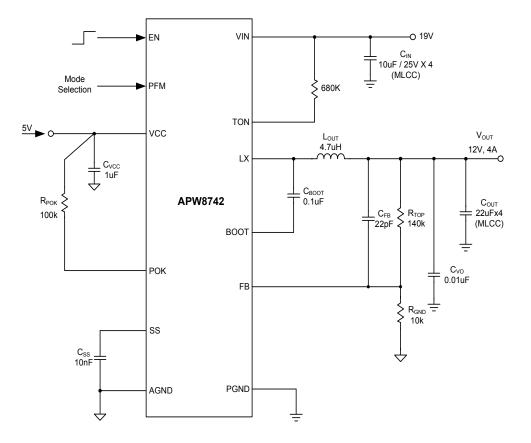
When  $V_{IN}$ =5V, Daul Power Input :





## **Typical Application Circuit**

When  $V_{IN}$ =19V,  $V_{OUT}$ =12V, High DutyApplication Circuit :





### **Function Description**

#### Constant-On-Time PWM Controller with Input Feed-Forward

The constant on-time control architecture is a pseudofixed frequency with input voltage feed-forward. This architecture relies on the output filter capacitors effective series resistance (ESR) to act as a current-sense resistor, so the output ripple voltage provides the PWMramp signal. In PFM operation, the high-side switch on-time controlled by the on-time generator is determined solely by a oneshot whose pulse width is inversely proportional to input voltage and directly proportional to output voltage. In PWM operation, the high-side switch on-time is determined by a switching frequency control circuit in the on-time generator block.

The switching frequency control circuit senses the switching frequency of the high-side switch and keeps regulating it at a constant frequency in PWM mode. The design improves the frequency variation and is more outstanding than a conventional constant on-time controller, which has large switching frequency variation over input voltage, output current and temperature. Both in PFM and PWM, the on-time generator, which senses input voltage on VIN pin, provides very fast on-time response to input line transients.

Another one-shot sets a minimum off-time (typical:250ns). The on-time one-shot is triggered if the error comparator is high, the low-side switch current is below the current-limit threshold, and the minimum off-time oneshot has timed out.

#### Pulse-Frequency Modulation (PFM) Mode

In PFMmode, an automatic switchover to pulse-frequency modulation (PFM) takes place at light loads. This switchover is affected by a comparator that truncates the low-side switch on-time at the inductor current zero crossing. This mechanism causes the threshold between PFM and PWM operation to coincide with the boundary between continuous and discontinuous inductor-current operation (also known as the critical conduction point). The on-time of PFM is given by:

$$T_{ON-PFM} = \frac{1}{F_{SW}} \times \frac{V_{OUT}}{V_{IN}}$$

Where  $\mathsf{F}_{\mathsf{SW}}$  is the nominal switching frequency of the converter in PWM mode.

The load current at handoff from PFM to PWM mode is given by:

$$\begin{split} I_{\text{LOAD}(\text{PFM to PWM})} = & \frac{1}{2} \times \frac{V_{\text{IN}} - V_{\text{OUT}}}{L} \times T_{\text{ON-PFM}} \\ & = \frac{V_{\text{IN}} - V_{\text{OUT}}}{2L} \times \frac{1}{F_{\text{SW}}} \times \frac{V_{\text{OUT}}}{V_{\text{IN}}} \end{split}$$

#### Forced-PWM Mode

The Forced-PWM mode disables the zero-crossing comparator, which truncates the low-side switch on-time at the inductor current zero crossing. This causes the low-side gate-drive waveform to become the complement of the high-side gate-drive waveform.

This in turn causes the inductor current to reverse at light loads while UG maintains a duty factor of  $V_{OUT}/V_{IN}$ . The benefit of Forced-PWM mode is to keep the switching frequency fairly constant. The Forced-PWM mode is most useful for reducing audio frequency noise, improving load-transient response, and providing sink-current capability for dynamic output voltage adjustment.

When  $V_{PFM}$  is above the PFM high threshold (2.5V, minimum), the converter is in forced-PWM mode. When  $V_{PFM}$  is below the PFM low threshold (0.5V, maximum), the chip is in automatic PFM/PWM Mode.

#### **Power-On-Reset**

A Power-On-Reset (POR) function is designed to prevent wrong logic controls when the VCC voltage is low. The POR function continually monitors the bias supply voltage on the VCC pin if at least one of the enable pins is set high. When the rising VCC voltage reaches the rising POR voltage threshold (4.35V, typical), the POR signal goes high and the chip initiates soft-start operations. Should this voltage drop lower than 4.25V (typical), the POR disables the chip.

#### En PinControl

When  $V_{\text{EN}}$  is above the EN high threshold (2.5V, minimum), the converter is enabled. When  $V_{\text{EN}}$  is below the EN low threshold (0.5V, maximum), the chip is in the shutdown and only low leakage current is taken from VCC.

#### Soft-Start

The APW8742 provides the programmed soft-start function to limit the inrush current. The soft-start time can be programmed by the external capacitor between SS and GND. Typical charge current is  $10\mu$ A, and the soft-start time can be calculated by the following formula:

 $\begin{array}{l} T_{_{SS}}=(C_{ss}\times V_{_{SS}}) \ / \ I_{SS} \\ V_{OUT} \ ready, \ V_{ss}=\ 1 \ V: T_{_{SS}} \ (\mu s) = 100 \ x \ C_{ss} \ (nF) \\ POK \ ready, \ V_{_{SS}}=\ 3.3V: T_{_{SS}} \ (\mu s) = 330 \ x \ C_{ss} \ (nF) \end{array}$ 

The APW8742 integrates soft-start circuits to ramp up the output voltage of the converter to the programmed regulation set point at a predictable slew rate. The slew rate of output voltage is internally controlled to limit the inrush current through the output capacitors during softstart process. When the EN pin is pulled above the rising EN threshold voltage, the device initiates a softstart process to ramp up the output voltage.

During soft-start stage before the POK pin is ready, the under voltage protection is prohibited. The over voltage and current limit protection functions are enabled. If the output capacitor has residue voltage before startup, both low-side and high-side MOSFETs are in off-state until the soft start voltage equal the  $V_{FB}$  voltage. This will ensure the output voltage starts from its existing voltage level. In the event of under-voltage, over-temperature or shutdown, the chip enables the soft-stop function. The soft-stop function discharges the output voltages using an internal MOSFET.



## Function Description (Cont.)

#### **Power Good Indicator**

POK is actively held low in shutdown and soft-start status. In the soft-start process, the POK is an open-drain. When the soft-start is finished, the POK is released. In normal operation, the POK window is from 90% to 125% of the converter reference voltage. When the output voltage has to stay within this window, POK signal will become high. When the output voltage outruns 90% or 125% of the target voltage, POK signal will be pulled low immediately. In order to prevent false POK drop, capacitors need to parallel at the output to confine the voltage deviation with severe load step transient.

#### **Under-Voltage Protection (UVP)**

In the process of operation, if a short circuit occurs, the output voltage will drop quickly. When load current is bigger than current limit threshold value, the output voltage will fall out of the required regulation range. The undervoltage protection circuit continually monitors the FB voltage after soft-start is completed. If a load step is strong enough to pull the output voltage lower than the under voltage threshold, the under voltage threshold is 70% of the nominal output voltage, the internal UVP delay counter starts to count. After 16 $\mu$ s de-bounce time, the device turns off both high side and low-side MOSEFET with latched. Toggling enable pin to low, or recycling VIN, will clear the latch and bring the chip back to operation.

#### **Over-Voltage Protection (OVP)**

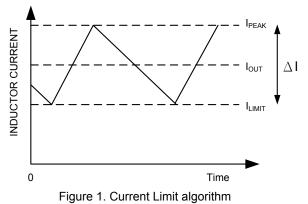
The over voltage function monitors the output voltage by FB pin. Should the FB voltage increase over 125% of the reference voltage due to the high-side MOSFET failure or for other reasons, the over voltage protection comparator designed with a  $3\mu$ s noise filter will force the low-side MOSFET gate driver fully turn on and latch high. This action actively pulls down the output voltage.

This OVP scheme only clamps the voltage overshoot, and does not invert the output voltage when otherwise activated with a continuously high output from low-side MOSFET driver. It's a common problem for OVP schemes with a latch. Once an over-voltage fault condition is set, it can only be reset by toggling EN or VIN power-on-reset signal.

#### **Current Limit**

The current limit circuit employs a "valley" current-sensing algorithm (See Figure 1). The APW8742 uses the low-side MOSFET's  $R_{DS(ON)}$  of the synchronous rectifier as a current-sensing element. If the magnitude of the current-sense signal at LX pin is above the current-limit threshold 15A(minimum), the PWM is not allowed to initiate a new cycle. The actual peak current is greater than the current-limit threshold by an amount equal to the inductor ripple current. Therefore, the exact current-limit characteristic and maximum load capability are a function of the sense resistance, inductor value, and input voltage.

Current Limit( Cont.)



The PWM controller uses the low-side MOSFET's onresistance  $R_{\text{DS}(\text{ON})}$  to monitor the current for protection against shorted outputs. The MOSFET's  $R_{\text{DS}(\text{ON})}$  is varied by temperature and gate to source voltage, the user should determine the maximum  $R_{\text{DS}(\text{ON})}$  in manufacture's datasheet.

The PCB layout guidelines should ensure that noise and DC errors do not corrupt the current-sense signals at LX. Place the hottest power MOSEFT's as close to the IC as possible for best thermal coupling. When combined with the under-voltage protection circuit, this current-limit method is effective in almost every circumstance.

#### **Over-Temperature Protection (OTP)**

When the junction temperature increases above the rising threshold temperature  $T_{OTR}$ , the IC will enter the over temperature protection state that suspends the PWM, which forces the UG and LG gate drivers output low. The thermal sensor allows the converters to start a start-up process and regulate the output voltage again after the junction temperature cools by 45°C. The OTP designed with a 45°C hysteresis lowers the average  $T_J$  during continuous thermal overload conditions, which increases lifetime of the APW8742.

# Programming the On-Time Control and PWM Switching Frequency

The APW8742 does not use a clock signal to produce PWM. The device uses the constant on-time control architecture to produce pseudo-fixed frequency with input voltage feed-forward. The on-time pulse width is proportional to output voltage  $V_{\text{OUT}}$  and inverse proportional to input voltage  $V_{\text{IN}}$ . In PWM, the on-time calculation is written as below equation.

$$T_{_{ON}} = \frac{26.3 \times 10^{-12} \times R_{_{TON}}(\Omega)}{V_{_{N}}(V)} \qquad .....(1)$$



### **Function Description (Cont.)**

Where:

 $R_{\text{TON}}$  is the resistor connected from TON pin to VIN pin. Furthermore, The approximate PWM switching frequency is written as:

$$T_{ON} = \frac{D}{F_{SW}}, F_{SW} = \frac{V_{OUT}/V_{IN}}{T_{ON}}$$

Where:

 $F_{swis}$  the PWM switching frequency.

It is useful to use formula (1) to set an accurate switching frequency for low duty application if the duty is less than 15%(D < 0.15). However, when the duty is more than 15% (D > 0.15), the formula (2) is suggested to cover the high duty application.



### **Application Information**

#### **Output Inductor Selection**

The output voltage is adjustable from 0.8V to 12V with a resistor-divider connected with FB, GND, and converter's output. Using 1% or better resistors for the resistor-divider is recommended. The output voltage is determined by:

$$V_{\text{OUT}} = 0.8 \times (1 + \frac{R_{\text{TOP}}}{R_{\text{GND}}})$$

Where 0.8 is the reference voltage,  $R_{\text{TOP}}$  is the resistor connected from converter's output to FB, and  $R_{\text{GND}}$  is the resistor connected from FB to GND. Suggested  $R_{\text{GND}}$  is in the range from 1k to 100k. To prevent stray pickup, locate resistors  $R_{\text{TOP}}$  and  $R_{\text{GND}}$  close to APW8742.

#### **Output Inductor Selection**

The duty cycle (D) of a buck converter is the function of the input voltage and output voltage. Once an output voltage is fixed, it can be written as:

$$\mathsf{D} = \frac{\mathsf{V}_{\mathsf{OUT}}}{\mathsf{V}_{\mathsf{IN}}}$$

The inductor value (L) determines the inductor ripple current,  $I_{RIPPLE}$ , and affects the load transient response. Higher inductor value reduces the inductors ripple current and induces lower output ripple voltage. The ripple current and ripple voltage can be approximated by:

$$I_{\text{RIPPLE}} = \frac{V_{\text{IN}} - V_{\text{OUT}}}{F_{\text{SW}} \times L} \times \frac{V_{\text{OUT}}}{V_{\text{IN}}}$$

Where  $F_{sw}$  is the switching frequency of the regulator. Although the inductor value and frequency are increased and the ripple current and voltage are reduced, a tradeoff exists between the inductor's ripple current and the regulator load transient response time.

A smaller inductor will give the regulator a faster load transient response at the expense of higher ripple current. Increasing the switching frequency ( $F_{sw}$ ) also reduces the ripple current and voltage, but it will increase the switching loss of the MOSFETs and the power dissipation of the converter. The maximum ripple current occurs at the maximum input voltage.

A good starting point is to choose the ripple current to be approximately 30% of the maximum output current. Once the inductance value has been chosen, selecting an inductor that is capable of carrying the required peak current without going into saturation. In some types of inductors, especially core that is made of ferrite, the ripple current will increase abruptly when it saturates. This results in a larger output ripple voltage. Besides, the inductor needs to have low DCR to reduce the loss of efficiency.

#### **Output Capacitor Selection**

Output voltage ripple and the transient voltage deviation are factors that have to be taken into consideration when selecting an output capacitor. Higher capacitor value and lower ESR reduce the output ripple and the load transient drop. Therefore, selecting high performance low ESR capacitors is recommended for switching regulator applications.

#### **Output Capacitor Selection (Cont.)**

In addition to high frequency noise related to MOSFET turn-on and turnoff, the output voltage ripple includes the capacitance voltage drop  $\Delta V_{\text{COUT}}$  and ESR voltage drop  $\Delta V_{\text{ESR}}$  caused by the AC peak-to-peak inductor's current. These two voltages can be represented by:

$$\Delta C_{\text{OUT}} = \frac{I_{\text{RIPPLE}}}{8 \times C_{\text{OUT}} \times F_{\text{SW}}}$$

$$\Delta V_{\text{ESR}} = I_{\text{RIPPLE}} \times R_{\text{ESR}}$$

These two components constitute a large portion of the total output voltage ripple. In some applications, multiple capacitors have to be paralleled to achieve the desired ESR value. If the output of the converter has to support another load with high pulsating current, more capacitors are needed in order to reduce the equivalent ESR and suppress the voltage ripple to a tolerable level. A small decoupling capacitor (1 $\mu$ F) in parallel for bypassing the noise is also recommended, and the voltage rating of the output capacitors are also must be considered.

To support a load transient that is faster than the switching frequency, more capacitors are needed for reducing the voltage excursion during load step change. Another aspect of the capacitor selection is that the total AC current going through the capacitors has to be less than the rated RMS current specified on the capacitors in order to prevent the capacitor from over-heating.

#### Input Capacitor Selection

The input capacitor is chosen based on the voltage rating and the RMS current rating. For reliable operation, selecting the capacitor voltage rating to be at least 1.3 times higher than the maximum input voltage. The maximum RMS current rating requirement is approximately  $I_{OUT}/2$ , where  $I_{OUT}$  is the load current. During power-up, the input capacitors have to handle great amount of surge current. For low-duty notebook applications, ceramic capacitor is recommended. The capacitors must be connected between the drain of high-side MOSFET and the source of low-side MOSFET with very low-impedance PCB layout.

#### Thermal Consideration

Because the APW8742 build-in high-side and low-side MOSFET, the heat dissipated may exceed the maximum junction temperature of the part in applications. If the junction temperature reaches approximately 150°C, both power switches will be turned off and the LX node will become high impedance. To avoid the APW8742 from exceeding the maximum junction temperature, the user will need to do some thermal analysis. The goal of the thermal analysis is to determine whether the power dissipated exceeds the maximum junction temperature of the part. The main power dissipated by the part is approximated:

 $P_{UPPER} = I_{OUT}^2 (1+TC)(R_{DS(ON)})D + 0.5(I_{OUT})(V_{IN})(t_{SW})F_{SW}$ 

$$P_{LOWER} = I_{OUT}^2 (1 + TC)(R_{DS(ON)})(1 - D)$$



# Application Information (Cont.)

$$\begin{split} I_{\text{OUT}} & \text{is the load current} \\ \text{TC is the temperature dependency of } R_{\text{DS(ON)}} \\ F_{\text{SW}} & \text{is the switching frequency} \\ t_{\text{SW}} & \text{is the switching interval} \end{split}$$

#### D is the duty cycle

Note that both internal MOSFETs have conduction losses while the upper MOSFET include an additional transition loss. The switching internal,  $t_{SW}$ , is the function of the reverse transfer capacitance  $C_{RSS}$ . The (1+TC) term factors in the temperature dependency of the  $R_{DS(ON)}$  and can be extracted from the " $R_{DS(ON)}$  vs. Temperature" curve of the power MOSFET. In APW8742 case, the  $R_{DS(ON)}$  is about 22m $\Omega$  from specification table.

#### Layout Consideration

In any high switching frequency converter, a correct layout is important to ensure proper operation of the regulator. With power devices switching at higher frequency, the resulting current transient will cause voltage spike across the interconnecting impedance and parasitic circuit elements. As an example, consider the turn-off transition of the PWM MOSFET. Before turn-off condition, the MOSFET is carrying the full load current. During turn-off, current stops flowing in the MOSFET and is freewheeling by the low side MOSFET and parasitic diode. Any parasitic inductance of the circuit generates a large voltage spike during the switching interval. In general, using short and wide printed circuit traces should minimize interconnecting impedances and the magnitude of voltage spike. Besides, signal and power grounds are to be kept separate and finally combined using ground plane construction or single point grounding. The best tiepoint between the signal ground and the power groundis at the negative side of the output capacitor on each channel, where there is less noise. Noisy traces beneath the IC are not recommended. Below is a checklist for your layout:

- Keep the switching nodes (BOOT and LX) away from sensitive small signal nodes since these nodes are fast moving signals. Therefore, keep traces to these nodes as short as possible and there should be no other weak signal traces in parallel with theses traces on any layer.

- The large layout plane between the drain of the MOSFETs (VIN and LX nodes) can get better heat sinking.

The current sense resistor should be close to OCSET pin to avoid parasitic capacitor effect and noise coupling.
Decoupling capacitors, the resistor-divider, and boot capacitor should be close to their pins.

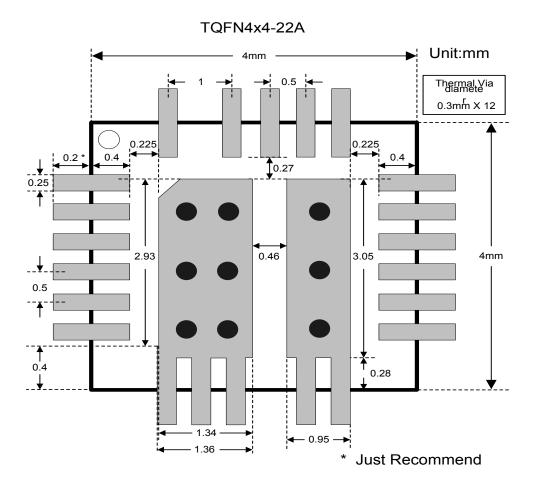
- The output bulk capacitors should be close to the loads. The input capacitor's ground should be close to the grounds of the output capacitors.

- Locate the resistor-divider close to the FB pin to minimize the high impedance trace. In addition, FB pin traces can't be close to the switching signal traces (BOOT and LX)



# **Application Information (Cont.)**

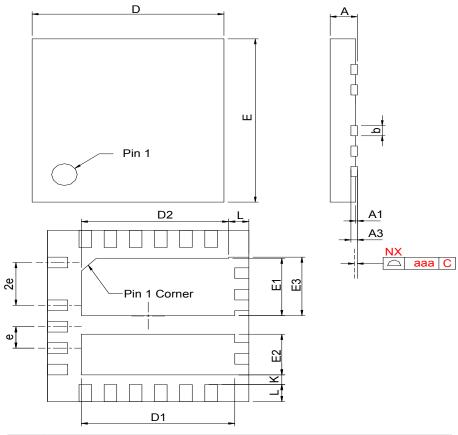
**Recommended Minimum Footprint** 





# **Package Information**

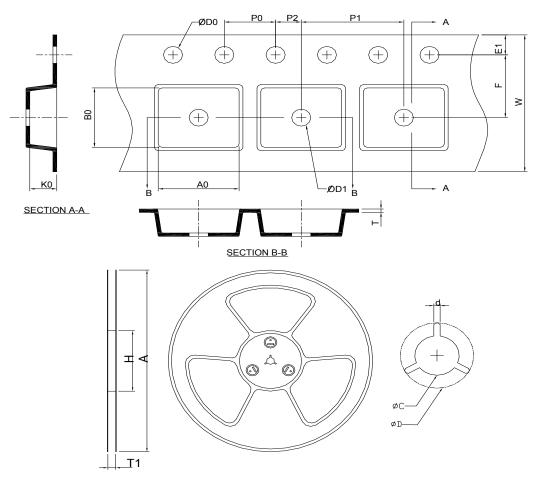
TQFN4x4-22A



S Y		TQFI	N4*4-22A	
MB	MILLI	METERS	INC	HES
O L	MIN.	MAX.	MIN.	MAX.
А	0.70	0.80	0.028	0.032
A1	0.00	0.05	0.000	0.002
A3	0.20	) REF	0.008	B REF
b	0.20	0.30	0.008	0.012
D	3.90	4.10	0.154	0.161
D1	2.95	3.15	0.116	0.124
D2	2.83	3.03	0.111	0.119
Е	3.90	4.10	0.154	0.161
E1	1.24	1.44	0.049	0.057
E2	0.85	1.05	0.033	0.041
E3	1.26	1.46	0.050	0.057
е	0.50	) BSC	0.020	) BSC
L	0.35	0.45	0.014	0.018
к	0.20		0.008	
aaa	0.	08	0.00	)3



# **Carrier Tape & Reel Dimensions**



Application	Α	Н	T1	С	d	D	W	E1	F
	330.0±2.00	50 MIN.	12.4+2.00 -0.00	13.0+0.50 -0.20	1.5 MIN.	20.2 MIN.	12.0±0.30	1.75±0.10	5.50±0.10
TQFN4x4	P0	P1	P2	D0	D1	Т	A0	B0	K0
	4.00±0.10	8.00±0.10	2.00±0.05	1.5+0.10 -0.00	1.5 MIN.	0.6+0.00 -0.40	4.30±0.20	4.30±0.20	1.00±0.20
									(mm)

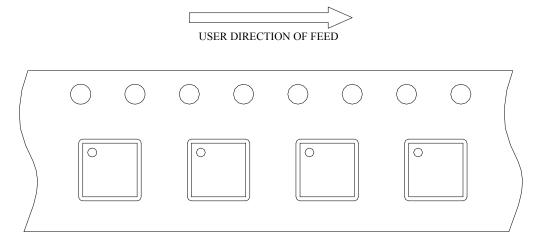
### **Devices Per Unit**

Package Type	Unit	Quantity
TQFN4x4	Tape & Reel	3000

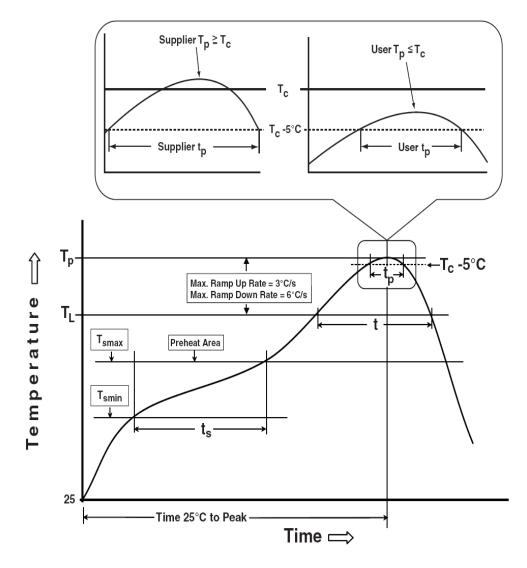


# **Taping Direction Information**

#### TQFN4x4-22A



# **Classification Profile**





### **Classification Reflow Profiles**

Profile Feature	Sn-Pb Eutectic Assembly	Pb-Free Assembly			
$\begin{array}{c} \textbf{Preheat \& Soak} \\ \textbf{Temperature min} (\textbf{T}_{smin}) \\ \textbf{Temperature max} (\textbf{T}_{smax}) \\ \textbf{Time} (\textbf{T}_{smin} \text{ to } \textbf{T}_{smax}) (\textbf{t}_{s}) \end{array}$	100 ℃ 150 ℃ 60-120 seconds	150 ℃ 200 ℃ 60-120 seconds			
Average ramp-up rate $(T_{smax} \text{ to } T_{P})$	3 °C/second max.	3°C/second max.			
Liquidous temperature $(T_L)$ Time at liquidous $(t_L)$	183 °C 60-150 seconds	217 °C 60-150 seconds			
Peak package body Temperature $(T_p)^*$	See Classification Temp in table 1	See Classification Temp in table 2			
Time $(t_P)^{**}$ within 5°C of the specified classification temperature $(T_c)$	20** seconds	30** seconds			
Average ramp-down rate ( $T_p$ to $T_{smax}$ )	6 °C/second max.	6 °C/second max.			
Time 25°C to peak temperature	6 minutes max.	8 minutes max.			
* Tolerance for peak profile Temperature ( $T_p$ ) is defined as a supplier minimum and a user maximum. ** Tolerance for time at peak profile temperature ( $t_p$ ) is defined as a supplier minimum and a user maximum.					

Table 1. SnPb Eutectic Process – Classification Temperatures (Tc)

Package	Volume mm <sup>3</sup>	Volume mm <sup>3</sup>
Thickness	<350	≥350
<2.5 mm	235 °C	220 °C
≥2.5 mm	220 °C	220 °C

Table 2. Pb-free Process – Classification Temperatures (Tc)

Package	Volume mm <sup>3</sup>	Volume mm <sup>3</sup>	Volume mm <sup>3</sup>
Thickness	<350	350-2000	>2000
<1.6 mm	260 °C	260 °C	260 °C
1.6 mm – 2.5 mm	260 °C	250 °C	245 °C
≥2.5 mm	250 °C	245 °C	245 °C

### **Reliability Test Program**

Test item	Method	Description
SOLDERABILITY	JESD-22, B102	5 Sec, 245°C
HOLT	JESD-22, A108	1000 Hrs, Bias @ T <sub>i</sub> =125°C
PCT	JESD-22, A102	168 Hrs, 100%RH, 2atm, 121°C
ТСТ	JESD-22, A104	500 Cycles, -65°C~150°C
HBM	MIL-STD-883-3015.7	$VHBM \ge 2KV$
MM	JESD-22, A115	$VMM \ge 200V$
Latch-Up	JESD 78	10ms, $1_{tr} \ge 100 \text{mA}$



### **Customer Service**

#### Anpec Electronics Corp.

Head Office : No.6, Dusing 1st Road, SBIP, Hsin-Chu, Taiwan, R.O.C. Tel : 886-3-5642000 Fax : 886-3-5642050

Taipei Branch : 2F, No. 11, Lane 218, Sec 2 Jhongsing Rd., Sindian City, Taipei County 23146, Taiwan Tel : 886-2-2910-3838 Fax : 886-2-2917-3838

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